

<b>Notice of References Cited</b>	Application/Control No. 10/550,693	Applicant(s)/Patent Under Reexamination VARACHEZ ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	O	CA 2161059 A	04-1996	Canada	MEIER et al.	-----
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**NON-PATENT DOCUMENTS**

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